IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Ibrahim Abdulhalim, Mike Adel, Michael Friedmann and Michael

Faeyrman

Assignee:

KLA-Tencor Corporation

Title:

Periodic Patterns and Technique to Control Misalignment (As

Amended)

Serial No.:

09/833,084

Filing Date:

April 10, 2001

Docket No.:

11547 M-10703 US

San Francisco, California October 12, 2001

COMMISSIONER FOR PATENTS Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR § 1.97(b)

Dear Sir:

Pursuant to 37 C.F.R. § 1.56, § 1.97 and § 1.98, the documents listed on the accompanying form PTO-1449 are called to the attention of the Examiner for the above patent application. Copies of these documents are enclosed.

Citation of these documents shall not be construed as:

- 1. an admission that the documents are necessarily prior art with respect to the instant invention;
 - 2. a representation that a search has been made, other than as described above; or
- 3. an admission that the information cited herein is, or is considered to be, material to patentability as defined in § 1.56(b).

EXPRESS MAIL LABEL NO:

Respectfully submitted,

EL873075620US

James S. Hsue

Attorney for Applicants

Reg. No. 29,545

#799521

Serial No. 09/833,084

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